

Reference No.: A03090506 Report No.: EMCA03090506

Page: 1 of 48 Date:Oct. 07, 2003

Product Name:

Compact Board

Model No .:

PCM-8500

Applicant:

AAEON TECHNOLOGY INC.

5F, NO. 135, LANE 235, PAO CHIAO RD., HSIN-TIEN CITY, TAIPEL

TAIWAN, R.O.C.

Date of Receipt:

Sep. 05, 2003

Finished date of Test:

Oct. 01, 2003

Applicable Standards:

Emission

Immunity

EN 55022:1998, Class B

EN 55024:1998

EN 61000-3-2:1995+A1:1998

- IEC 61000-4-2:1995+A1:1998

+A2:1998

- IEC 61000-4-3:1995+A1:1998

EN 61000-3-3:1995+A1:1998

- IEC 61000-4-4:1995

- IEC 61000-4-5:1995

- IEC 61000-4-6:1996

- IEC 61000-4-8:1993

- IEC 61000-4-11:1994

We, Spectrum Research & Testing Laboratory Inc., hereby certify that one sample of the above was tested in our laboratory with positive results according to the above-mentioned standards. The records in the report are an accurate account of the results. Details of the results are given in the subsequent pages of this report.

Checked By

unyou Chen)

Date:

Approved By:

(Johnson Ho, Director)

Date: Oct. 67 2003

Lab Code: 200099-0



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1. DOCUMENT POLICY AND TEST STATEMENT

1.1 DOCUMENT POLICY

- The report shall not be reproduced except in full, without the written approval of SRT Lab, Inc.
- The report must not be used by the applicant to claim that the product is endorsed by NVLAP, TÜV, NEMKO and SRT.
- The NVLAP logo applies only to the applicable standards specified in this report.

1.2 TEST STATEMENT

- The test results in the report apply only to the unit tested by SRT Lab.
- There was no deviation from the requirements of test standards during the test.
- AC power source, 230 VAC/50 Hz, was used during the test.
- The EN 61000-3-2:1995+A1:1998+A2:1998(Harmonic test) and EN 61000-3-3:
 1995+A1:1998(Flicker test) are not included in the scope of NVLAP logo usage.
- The EN 61000-3-2:1995+A1:1998+A2:1998(Harmonic test) and EN 61000-3-3:
 1995+A1:1998(Flicker test) are included in the scope of TÜV, NEMKO and SRT logo usage.



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2. DESCRIPTION OF EUT AND TEST MODE

2.1 GENERAL DESCRIPTION OF EUT

PRODUCT	Compact Board
MODEL NO.	PCM-8500
POWER SUPPLY	DC from PC
CABLE	N/A

NOTE:

For more detailed information, please refer to the EUT's specification or user's manual provided by manufacturer.

2.2 DESCRIPTION OF EUT INTERNAL DEVICE

DEVICE	BRAND / MAKER	MODEL #	REMARK
POWER SUPPLY	SEVENTEAM	ST-300HLP	
FDD	TEAC	FD-235HF	
HDD	MAXTOR	4D040H2	
CD-ROM	AFREEY	CD-2052E	

NOTE:

- 1. The EUT was installed into a PC enclosure
- 2. The CPU installed on EUT is Intel Pentium4 2.4GHz, clock chip is 133MHz.
- 3. Frequency range to be measured.
 Radiated emission is 30MHz to 12GHz.

2.3 DESCRIPTION OF TEST MODE

The EUT was pre-tested under the following video resolution:

640x480, 1600x1200 and 2048x1536

The worst emission was found under 2048x1536 and therefore the test data of only this mode is recorded.



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3. DESCRIPTION OF APPLIED STANDARDS

The EUT is a kind of ITE interface device and according to the specifications provided by the applicant, it must comply with the requirements of the following standards:

EN 55022:1998, Class B

EN 61000-3-2:1995+ A1:1998+A2:1998

EN 61000-3-3:1995+A1:1998

EN 55024:1998

- IEC 61000-4-2:1995+A1:1998

- IEC 61000-4-3:1995+A1:1998

- IEC 61000-4-4:1995

- IEC 61000-4-5:1995

- IEC 61000-4-6:1996

- IEC 61000-4-8:1993

- IEC 61000-4-11:1994

All tests have been performed and recorded as the above standards.



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4. EMISSION TEST

4.1 CONDUCTED EMISSION TEST FOR POWER PORT

4.1.1 CONDUCTED EMISSION LIMIT

FREQUENCY (MHz)	Class A	(dBμV)	Class B (dBμV)		
PREGOENCT (MITZ)	Quasi-peak	Average	Quasi-peak	Average	
0.15 - 0.5	79	66	66 - 56	56 - 46	
0.5 - 5.0	73	60	56	46	
5.0 - 30.0	73	60	60	50	

NOTE:

- 1. The lower limit shall apply at the transition frequencies.
- 2. The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

4.1.2 TEST EQUIPMENT

The following test equipment was used for the test:

EQUIPMENT/ FACILITIES	SPECIFICATIONS	MANUFACTURER	MODEL#/ SERIAL#	DUE DATE OF CAL. & CAL. CENTER
EMI TEST	9 kHz TO	ROHDE &	ESCS30/	AUG. 2004
RECEIVER	2750 MHz	SCHWARZ	830245/012	ETC
LISN (for EUT)	50 μH, 50 ohm	SOLAR	8012-50-R-24-BNC	JUN. 2004
LISIN (IOI EUT)	50 μπ, 50 01111	ELECTRONICS	/ 924839	ETC
LISN	FOUL FO ohm	SOLAR	9252-50-R-24-BNC	JUN. 2004
(for Peripheral)	50μH, 50 ohm	ELECTRONICS	/ 951318	ETC
50 ohm	50 ohm	HP	11593A/	MAY 2004
TERMINATOR	50 OHH	ПР	2	ETC
COAXIAL	3m	SUNCITY	J400/	JUL. 2004
CABLE	SIII	SUNCITY	3M	SRT
ISOLATION	N/A	APC	AFC-11015/	N/A
TRANSFORMER	IN/A	APC	F102040016	IN/A
FILTED	211NE 204	FII COII	FC-943/	NI/A
FILTER	2 LINE, 30A	FIL.COIL	771	N/A
CDOUND DLANE	2.3M (H) x	CDT	NI/A	APR. 2004
GROUND PLANE	2.4M (W)	SRT	N/A	SRT
CDOUND DLANE	2.4M (H) x	CDT	NI/A	APR. 2004
GROUND PLANE	2.4M (W)	SRT	N/A	SRT

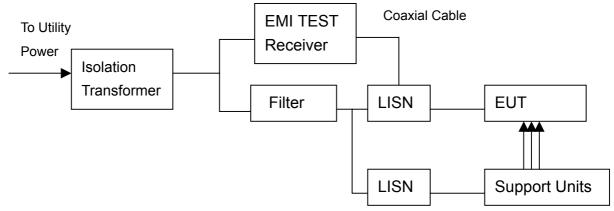
NOTE: The calibration interval of the above test equipment is one year and the calibrations are traceable to NML/ROC and NIST/USA.



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4.1.3 TEST SETUP



NOTE:

- 1. The EUT was put on a wooden table with 0.8m height above ground plane, and 0.4m away from reference ground plane (> 2mx2m).
- 2. For the actual test configuration, please refer to the photos of testing.
- 3. The serial no. of the LISN connected to EUT is 951318.
- 4. The serial no. of the LISN connected to support units is 924839.

4.1.4 TEST PROCEDURE

The EUT was tested according to the requirement of EN 55022:1998. The frequency spectrum from 0.15 MHz to 30 MHz was investigated. The LISN used was $50\Omega/50\mu H$ as specified. All readings were quasi-peak and average values with 10 kHz resolution bandwidth of the test receiver. The EUT system was operated in all typical methods by users. Both lines of the power mains of EUT were measured and the cables connected to EUT and support units were moved to find the maximum emission levels for each frequency.

First, Find the margin or higher points at least 6 points by software, then use manual to find the maximum data. The procedure is referred on the test procedure of SRT LAB.



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4.1.5 DESCRIPTION OF SUPPORT UNIT

The EUT was configured by the requirement of EN 55022:1998. All interface ports were connected to the appropriate support units via specific cables. The support units and cables are listed below.

NO	DEVICE	BRAND	MODEL #	CABLE
1	MONITOR	SAMSUNG	PG17IS	1.5m unshielded power cord 1.2m shielded data cable
2	PRINTER	EPSON	STYLUS C20SX	1.5m unshielded power cord 1.2m shielded data cable
3	MODEM	ACEEX	DM-1414	1.5m unshielded DC power cable 1.2m shielded data cable
4	KEYBOARD	MITSUMI	KPQ-E99ZC-13	1.2m unshielded data cable
5	MOUSE	LOGITECH	M-S34	1.2m unshielded data cable
6	COM MOUSE	LOGITECH	M-M35	1.2m unshielded data cable
7	COM MOUSE	LOGITECH	M-M35	1.2m unshielded data cable
8	COM MOUSE	СОМВО	AM-737-C2	1.2m unshielded data cable
9	USB MOUSE	HP	M-S48A	1.2m unshielded data cable
10	USB HDD	HP	M-S48A	1.2m unshielded data cable
11	USB HDD	HP	M-S48A	1.2m unshielded data cable
12	USB HDD	HP	M-S48A	1.2m unshielded data cable
13	SPEAKER	JS	J-205A	1.5m unshielded power cord 1.5m unshielded data cable
14	MIC	TAKY	UDM-606	1.8m unshielded data cable
15	WALKMAN	AIWA	HS-P102	1.2m unshielded data cable

NOTE: For the actual test configuration, please refer to the photos of testing.

4.1.6 EUT OPERATING CONDITION

- 1. Under Windows 98 ran "EMI TEST", "WIN FCC" and "Media Player" programs.
- 2. PC sent "H" pattern or accessed the following peripherals directly or via EUT:
 - Color Monitor
 - RS232
 - Keyboard
 - Mouse
 - Printer
 - FDD
 - HDD
- 3. Accessed data from internet.



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4.1.7 TEST RESULT

Temperature: 26 °C Humidity: 45 %RH

Ferquency Range: 0.15 – 30 MHz Tested Mode: N/A

Receiver Detector: Q.P. and AV. Tested By: Nissan Yu

Tested Date: Sep. 26, 2003

Power Line Measured: Line

Freq.	Correct. Factor	ictor (dB _μ V)		Emission Level (dBμV)		Limit (dBµV)		Margin (dB)	
	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
0.150	0.20	39.7	33.8	39.9	34.0	66.0	56.0	-26.1	-22.0
0.896	0.20	27.0	26.8	27.2	27.0	56.0	46.0	-28.8	-19.0
1.646	0.20	26.9	26.5	27.1	26.7	56.0	46.0	-28.9	-19.3
2.170	0.20	25.3	25.0	25.5	25.2	56.0	46.0	-30.5	-20.8
15.279	0.50	35.9	31.1	36.4	31.6	60.0	50.0	-23.6	-18.4
25.127	0.70	50.7	46.5	51.4	47.2	60.0	50.0	-8.6	-2.8

Power Line Measured: Neutral

Freq.	Correct. Factor	actor (dBμV)		Emission Level (dBµV)		Limit (dBμV)		Margin (dB)	
, ,	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
0.154	0.20	38.8	35.7	39.0	35.9	65.8	55.8	-26.8	-19.9
0.896	0.20	25.1	25.0	25.3	25.2	56.0	46.0	-30.7	-20.8
1.646	0.20	24.4	24.2	24.6	24.4	56.0	46.0	-31.4	-21.6
2.392	0.20	28.3	27.5	28.5	27.7	56.0	46.0	-27.5	-18.3
14.310	0.49	35.1	29.4	35.6	29.9	60.0	50.0	-24.4	-20.1
25.119	0.70	50.6	47.2	51.3	47.9	60.0	50.0	-8.7	-2.1

NOTE:

- 1. Measurement uncertainty is +/-2dB
- 2. Emission level = Reading value + Correction factor
- 3. Correction Factor = Cable loss + Insertion loss of LISN
- 4. Margin value = Emission level Limit
- 5. The emission of other frequencies were very low against the limit.
- 6. "-": The Quasi-peak reading value also meets average limit and measurement with the average detector is unnecessary.



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4.2 RADIATED EMISSION TEST

4.2.1 RADIATED EMISSION LIMIT

EN 55022:1998 limits of radiated emission measurement for frequency below 1000 MHz

FREQUENCY (MHz)	Class A (at 10m)	Class B (at 10m)
FREQUENCT (MITZ)	dBμV/m	dBμV/m
30 – 230	40	30
230 - 1000	47	37

NOTE:

- 1. The lower limit shall apply at the transition frequencies.
- 2. Emission level (dB μ V/m) = 20 log Emission level (μ V/m).

4.2.2 TEST EQUIPMENT

The following test equipment was used during the radiated emission test:

EQUIPMENT/ FACILITIES	SPECIFICATIONS	MANUFACTURER	MODEL#/ SERIAL#	DUE DATE OF CAL. & CAL. CENTER
EMI TEST	20 MHz TO	ROHDE &	ESVS30/	AUG. 2004
RECEIVER	1000 MHz	SCHWARZ	841997/003	ETC
BI-LOG	25 MHz TO	EMCO	3142/	APR. 2004
ANTENNA	2 GHz	EMCO	9701-1124	SRT
OATS	3 – 10 M	SRT	SRT-1	APR. 2004
UAIS	MEASUREMENT	SKI	3K1-1	SRT
COAXIAL	OEM	CLINCITY	J400/	AUG. 2004
CABLE	25M	SUNCITY	25M	SRT
FILTED	OLINE OOA	FIL COIL	FC-943/	NI/A
FILTER	2 LINE, 30A	FIL.COIL	869	N/A
FREQUENCY	NI/A	ADO	AFC-2KBB/	AUG. 2004
CONVERTER	N/A	APC	F100030031	SRT

NOTE:

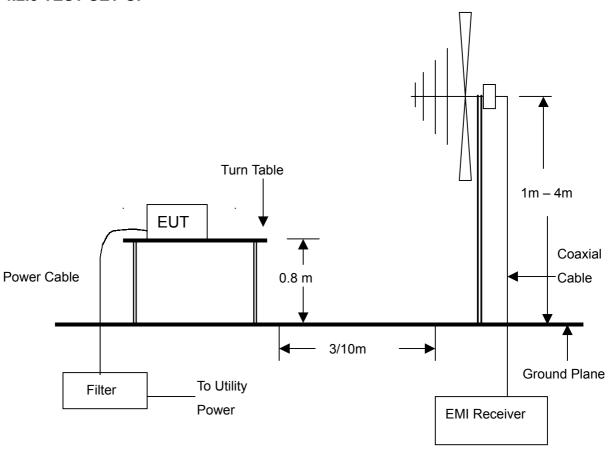
- 1. The calibration interval of the above test equipment is one year and the calibrations are traceable to NML/ROC and NIST/USA.
- 2. The Open Area Test Site (SRT-1) is registered by FCC with No. 90957 and VCCI with No. R-1081.
- 3. The Open Area Test Site (SRT-2) is registered by FCC with No. 98458 and VCCI with No. R-1168.



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4.2.3 TEST SET-UP



NOTE:

- 1. The EUT system was put on a wooden table with 0.8m heights above a ground plane.
- 2. For the actual test configuration, please refer to the photos of testing.

4.2.4 TEST PROCEDURE

The EUT was tested according to the requirement of EN 55022:1998. The measurements were made at an open area test site with 10 meter measurement distance. The frequency spectrum measured from 30 MHz to 1 GHz. All readings were quasi-peak values with 120 kHz resolution bandwidth of the test receiver. The EUT system was operated in all typical methods by users. The cables connected to EUT and support units were moved to find the maximum emission levels for each frequency.

First, Find the margin or higher points at least 6 points by software, then use manual to find the maximum data. The procedure is referred on the test procedure of SRT LAB.



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4.2.5 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

4.2.6 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.



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4.2.7 TEST RESULT

Temperature: 30 °C Humidity: 46 %RH

Ferquency Range: 30 – 1000 MHz Measured Distance: 10m

Receiver Detector: Q.P. Tested Mode: N/A

Tested By: Nissan Yi Tested Date: Oct. 01, 2003

Antenna Polarization:Horizontal

Frequency (MHz)	Cable Loss (dB)	Antenna Factor (dB/m)	Reading Data (dBµV)	Emission Level (dBµV/m)	Limit (dBµV/m)	Margin (dB)	AZ(°)	EL(m)
159.7670	1.24	8.87	16.9	27.0	30.0	-3.0	256.6	4.0
184.3490	1.28	10.46	14.0	25.7	30.0	-4.3	96.6	4.0
208.8970	1.33	10.06	12.1	23.5	30.0	-6.5	125.5	4.0
333.0570	1.74	15.09	14.2	31.0	37.0	-6.0	56.6	4.0
499.8600	2.17	18.57	8.0	28.7	37.0	-8.3	236.6	4.0
566.5110	2.32	19.98	8.2	30.5	37.0	-6.5	222.2	4.0

Antenna Polarization: Vertical

Frequency (MHz)	Cable Loss (dB)	Antenna Factor (dB/m)	Reading Data (dBµV)	Emission Level (dBµV/m)	Limit (dBµV/m)	Margin (dB)	AZ(°)	EL(m)
159.7670	1.24	8.87	16.8	26.9	30.0	-3.1	12.5	1.0
184.3490	1.28	10.46	12.0	23.7	30.0	-6.3	22.2	1.0
208.8970	1.33	10.06	13.0	24.4	30.0	-5.6	36.6	1.0
333.0570	1.74	15.09	13.6	30.4	37.0	-6.6	96.6	1.0
499.8600	2.17	18.57	10.3	31.0	37.0	-6.0	325.5	1.0
566.5110	2.32	19.98	7.0	29.3	37.0	-7.7	322.2	1.0

NOTE:

- 1. Measurement uncertainty is +/-4dB.
- 2. "*": Measurement does not apply for this frequency.
- 3. Emissiom Level = Reading Value + Ant. Factor + Cable Loss.
- 4. The field strength of other emission frequencies were very low against the limit.



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4.3 CURRENT HARMONICS TEST

4.3.1 LIMIT

For Class A Equipment

EVEN H	ARMONICS	ODD HA	RMONICS
HARMONICS ORDER	LIMIT (Amp.)	HARMONICS ORDER	LIMIT (Amp.)
2	1.08	3	2.30
4	0.43	5	1.14
6	0.30	7	0.77
8 < n < 40	0.23 x 8 / n	9	0.40
		11	0.33
		13	0.21
		15 < n < 39	0.15 x 8 / n

For Class D Equipment

Harmonics Order	Max. permissible harmonics	Max. permissible harmonics			
n	current per watt (mA/W)	current (A)			
Odd Harmonics only					
3	3.4	2.30			
5	1.9	1.14			
7	1.0	0.77			
9	0.5	0.40			
11	0.35	0.33			
13	0.30	0.21			
15 ≤ n ≤ 39	3.85 / n	0.15 x 15 / n			

NOTE:

- 1. Class A and Class D are judged by test equipment automatically as per Section 5 of EN 61000-3-2:1995
- 2. The above limits for Class D equipment are for all applications having an active input power > 75 W. No limits apply for equipment with an active input power up to and including 75 W.



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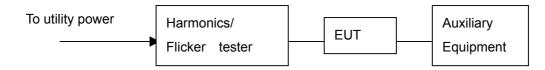
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4.3.2 TEST EQUIPMENT

EQUIPMENT / FACILITIES	MANUFACTURER	MODEL#/	DUE DATE OF CAL. & CAL. CENTER
MAIN UNIT	HP	6842A/ 3734A00212	MAR. 2004 AGILENT

NOTE: The calibration interval of the above test equipment is one year and the calibrations are traceable to NML/ROC and NIST/USA.

4.3.3 TEST SETUP



NOTE:

- 1. The EUT system was put on a wooden table with 0.8m high.
- 2. For the actual test configuration, please refer to the photos of testing.

4.3.4 TEST PROCEDURE

According to EN61000-3-2:1995+A1:1998+A2:1998

4.3.5 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

4.3.6 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.



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4.3.7 TEST RESULT

Temperature: 26 °C Humidity: 47% RH

Fundamental Current: 0.472A Max. Power

Voltage: 225.6Vrms Consumption: 101.2W

Power Factor: 0.939 Tested Mode: N/A

Tested By: Nissan Yi Test Date: Sep. 27, 2003

Maximum Reading Data:

Odd Harm. Order	Reading Data (A)	Limit (A)	Test Result
17	0.0148	0.1324	PASS



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4.4 VOLTAGE FLUCTUATIONS

4.4.1 **LIMIT**

Short-team flicker (P_{st}): 1.0 Long-term flicker (P_{lt}): 0.65

Relative steady-state voltage change (D_c) : ≤ 3%

Relative voltage change characteristic (D (t)) > 3%; $(T_{D(t)})$: \leq 200 ms

Maximum relative voltage change (D_{max}) : ≤ 4%

TEST ITEM	LIMIT	NOTE
P _{st}	1.0	P _{st} means short-term flicker indicator.
P _{lt}	0.65	P _{lt} means long-term flicker indicator.
T _{D(t)} (ms)	200	$T_{D(t)}$ means maximum time that D (t) exceeds 3 %.
D _{max} (%)	4%	D _{max} means maximum relative voltage change.
D _c (%)	3%	D _c means relative steady-state voltage change

4.4.2 TEST EQUIPMENT

EQUIPMENT / FACILITIES	MANUFACTURER	MODEL#/	DUE DATE OF CAL. & CAL. CENTER
MAIN UNIT	HP	6842A/	MAR. 2004
		3734A00212	AGILENT

NOTE: The calibration interval of the above test equipment is one year and the calibrations are traceable to NML/ROC and NIST/USA.

4.4.3 TEST PROCEDURE

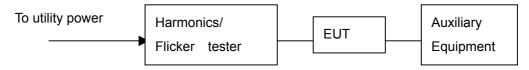
According to EN 61000-3-3:1995+A1:1998



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4.4.4 TEST SETUP



NOTE: 1. The EUT system was put on a wooden table with 0.8m high.

2. For the actual test configuration, please refer to the photos of testing.

4.4.5 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

4.4.6 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.



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4.4.7 TEST RESULT

26 °C Humidity: Temperature: 47% RH Input Voltage: Observation 225.6Vrms Period: 1Hr Ampere: 0.5Arms Power Factor: 0.932 Tested Mode: N/A Tested By: Nissan Yi Sep. 27, 2003 Test Date:

Test Result:

TEST PARAMETER	MEASUREMENT VALUE	LIMIT	TEST RESULT
P _{st}	0.07	1.0	PASS
P _{lt}	0.07	0.65	PASS
T _{D(t)} (ms)	0	200	PASS
D _{max} (%)	0%	4%	PASS
D _c (%)	0%	3%	PASS

NOTE:

- 1. P_{st} means short-term flicker indicator.
- 2. P_{lt} means long-term flicker indicator.
- 3. $T_{D(t)}$ means maximum time that D(t) exceeds 3 %.
- 4. D_{max} means maximum relative voltage change.
- 5. D_c means relative steady-state voltage change.
- 6. N/A: Not applicable.



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5. ELECTROSTATIC DISCHARGE IMMUNITY TEST

5.1 TEST EQUIPMENT

EQUIPMENT / FACILITIES	MANUFACTURER	MODEL#/ SERIAL#	DUE DATE OF CAL. & CAL. CENTER
ESD SIMULATOR	NOISEKEN	ESS-100L(A)/TC-815P/ 8099C02238/7099C02	NOV. 2003 ETC
HCP (1.6M x 0.8M)	SRT	WITH TWO 470k OHM	APR. 2004 SRT
VCP (0.5M x 0.5M)	SRT	WITH TWO 470k OHM CABLE	APR. 2004 SRT
GROUND PLANE (3.4M x 2.4M)	SRT	N/A	N/A

NOTE: The calibration interval of the above test equipment is one year and the calibrations are traceable to NML/ROC and NIST/USA.

5.2 TEST PROCEDURE

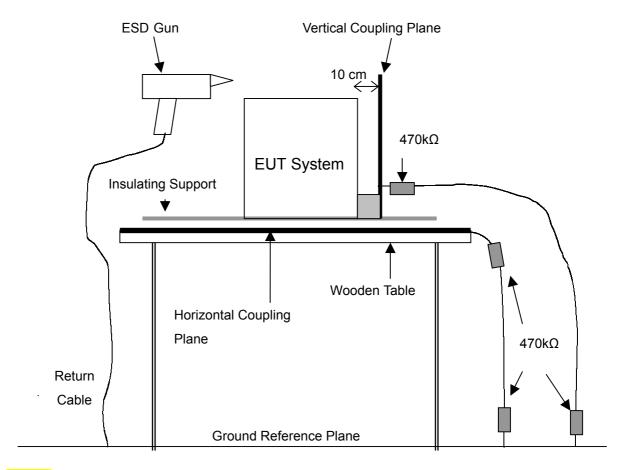
According to IEC/EN 61000-4-2:1995+A1:1998



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5.3 TEST SET-UP



NOTE:

- 1. The wooden table should be 0.8m high for table top EUT and 0.1m for floor-standing EUT.
- 2. For the actual test configuration, please refer to the photos of testing.
- 3. A distance of 1m minimum was provided between EUT and walls / other metallic structure.



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5.4 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

5.5 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.

5.6 TEST CONDITION AND PERFORMANCE CRITERION

1. Test condition

(1) R-C Network :330 Ω , 150 pF (2) Test level: Air Discharge : $\pm 2kV$, $\pm 4kV$, $\pm 8kV$

Contact discharge : ±2kV, ±4kV HCP discharge : ±2kV, ±4kV VCP discharge : ±2kV, ±4kV

(3) Discharge mode : Single discharge

(4) Discharge period : at least 1 s

(5) Discharge polarity : Positive and Negative

(6) Number of discharge : Minimum 50 times at each test point of contact

discharge and at least 200 times of discharge to EUT in total. Minium 10 times at each test area

of air discharge selected.

2. Standard requirement : Criterion B

3. Performance criterion

(1) Criterion A Normal performance during test

(2) Criterion B : Temporary degradation or loss of function or

performance which is self-recoverable

(3) Criterion C : Temporary degradation or loss of function or

performance which requires operator

intervention system reset



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5.7 SUMMARY OF TEST RESULT

Temperature:26 °CHumidity:43% RHTest Mode:N/ATested By:Nissan YiAtmospheric Air Pressure:101.2 kPaTested Date:Sep. 30, 2003

Test Result: Criterion A pass

SEVERITY	COUPLING MODE & TEST OBSERVATION					
LEVEL	AIR DISCHARGE	CONTACT DISCHARGE	НСР	VCP		
±2kV	Α	А	А	А		
±4kV	A	Α	А	A		
±8kV	A	NR	NR	NR		

NOTE:

Description of test observation:

A: There was no change compared with initial operation during the test.

NR: No requirement

Description of test points:

- 1. Screws of USB port.
- 2. Bracket of VGA port.
- 3. Bracket of Keyboard port.
- 4. VGA connector of EUT.
- 5. HCP.
- 6. VCP.



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6. RADIATED IMMUNITY TEST

6.1 TEST EQUIPMENT

EQUIPMENT /	MANUFACTURER	MODEL#/	DUE DATE OF CAL.
FACILITIES		SERIAL#	& CAL. CENTER
SIGNAL	HP	8648A/	JUN. 2004
GENERATOR		3636A022776	ETC
ANTENNA	SCHAFFNER	CBL6111/	AUG. 2004
	CHASE	1188	SRT
FIELD SENSOR	AMPLIFIER	FP2000/	DEC. 2003
	RESEARCH	28499	ETC
POWER	AMPLIFIER	100W1000M1/	JUN. 2004
AMPLIFIER	RESEARCH	19509	ETC
ANECHOIC	SRT	A05/	OCT. 2003
CHAMBER		SRT005	SRT
V/M MONITOR	A.R.	FM2000/ 15970	N/A
MONITOR	SHIN	SI-609/ 905130	N/A
CCD	TOPVIEW	N/A/ 95113762	N/A
ABSORBER	ETS	N/A	N/A
COAXIAL	SUNCITY	J400/	APR. 2004
CABLE		30CM	SRT
COAXIAL	TIME	LMR-400/	APR. 2004
CABLE		4M	SRT

NOTE: The calibration interval of the above test equipment is one year and the calibrations are traceable to NML/ROC and NIST/USA.

6.2 TEST PROCEDURE

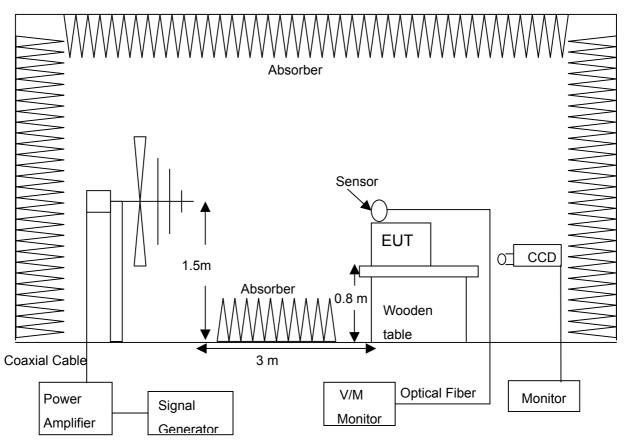
According to IEC/EN 61000-4-3:1995+A1:1998



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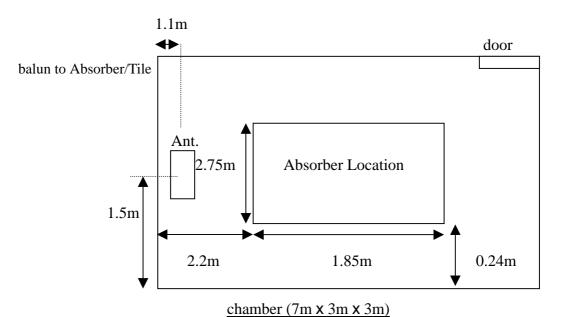
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6.3 TEST SETUP



NOTE:

- 1. The wooden table should be 0.8m high for table top EUT and 0.1m for floor-standing EUT.
- 2. For the actual test configuration, please refer to the photos of testing.





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6.4 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

6.5 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.

6.6 TEST CONDITION / PERFORMANCE CRITERIA

1. Test condition

(1) Source voltage and frequency : 230V/50Hz, single phase

(2) Sweeping frequency : 80MHz – 1 GHz

(3) Test level : 3V/m, the frequncy step is 1%

(4) The four sides of EUT are tested : front, rear, left, right

(5) Modulation : 80%AM, 1kHz Dwell time for each

frequency is 3 sec.

(6) Antenna Polarization : Horizontal and Vertical

(7) Standard requirement : Criterion A

2. Performance criterion

(1) Criterion A : Normal performance during test

(2) Criterion B : Temporary degradation or loss of function or

performance which is self-recoverable.

(3) Criterion C : Temporary degradation or loss of function

or performance which requires operator

intervention system reset.

6.7 TEST RESULT

Temperature:	26°C	Humidity:	45% RH
Test Mode:	N/A	Tested By:	Nissan Yi
		Tested Date:	Sep. 30, 2003

Test Result : Criterion A pass

FREQUENCY	LEVEL	MODULATION	DIRECTION	TEST R	ESULT RION)
				Н	V
80MHz - 1GHz	3V/m	80%AM, 1kHz	FRONT	Α	Α
80MHz - 1GHz	3V/m	80%AM, 1kHz	REAR	Α	Α
80MHz - 1GHz	3V/m	80%AM, 1kHz	LEFT	Α	Α
80MHz - 1GHz	3V/m	80%AM, 1kHz	RIGHT	Α	Α

NOTE:

Description of test observation:

A: There was no change compared with initial operation during the test.



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7. ELECTRICAL FAST TRANSIENT / BURST IMMUNITY TEST

7.1 TEST EQUIPMENT

MANUFACTURER	MODEL # / SERIAL #	DUE DATE OF CAL & CAL CENTER
HAEFELY	PEFT-JUNIOR /	NOV. 2003 ETC
HAEFELV	TRENCH /	NOV. 2003
HAEFELT	080421-12	ETC
SRT	N/A	APR. 2004 SRT
	HAEFELY	MANUFACTURER SERIAL # PEFT-JUNIOR / 583-333-122 TRENCH / 080421-12

7.2 TEST PROCEDURE

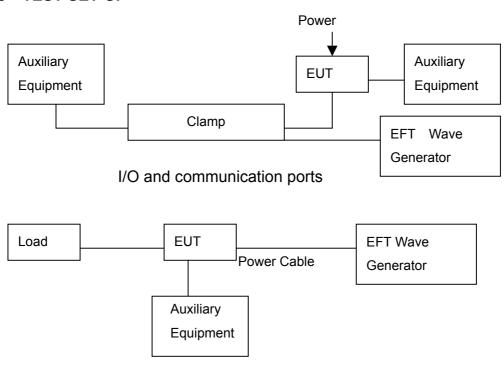
According to IEC/EN 61000-4-4:1995



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7.3 TEST SET-UP



Power supply ports

NOTE:

- 1. The EUT system was put on a wooden table with 0.8m height for table top EUT and 0.1m for floor-standing EUT above ground reference plane.
- 2. For the actual test configuration, please refer to the photos of testing.
- 3. The minimum distance between the EUT and all other conductive structure was more than 0.5m.
- 4. The minimum distance between the coupling plates of the coupling clamps (if used) and all over conductive structures, except the ground plane beneath the coupling clamp and beneath the EUT was more than 0.5m.
- 5. The power cable connecting EUT was controlled under 1m.

7.4 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

7.5 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.



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7.6 TEST CONDITION / PERFORMANCE CRITERIA

1. Test condition

(1) Source voltage and frequency: 230V/50Hz, single phase

(2) Pulse risetime and duration : 5ns / 50ns (3) Pulse repetition : 5kHz

(4) Polarity : Positive Polarization and Negative

Polarization

(5) Burst duration and period : 15ms / 300ms(6) Test duration : 61sec each line

(7) Time between test : 10Sec

(8) Severity levels : Power Line ±1kV

Signal/Control Line ±0.5kV

(9) Standard requirement : Criterion B

2. Performance criterion

(1) Criterion A : Normal performance during test

(2) Criterion B : Temporary degradation or loss of function or

performance which is self-recoverable.

(3) Criterion C : Temporary degradation or loss of function

or performance which requires operator

intervention system reset.

7.7 SUMMARY OF TEST RESULT

Temperature:27 °CHumidity:48% RHTest Mode:N/ATested By:Nissan YiAtmospheric Air Pressure:101.2 kPaTested Date:Sep. 30, 2003

Test Result : Criterion A pass

Voltage		0.25kV		0.5kV		1kV	
P	olarity	+	-	+	-	+	-
	L1	NR	NR	Α	Α	Α	Α
Test	L2	NR	NR	Α	Α	Α	Α
Line	GND	NR	NR	Α	Α	Α	Α
	Signal/ Control Line	А	А	А	Α	NR	NR

NOTE:

Description of test observation:

A: There was no change compared with initial operation during the test.

NR: No requirement



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8. SURGE TEST (POWER LINE)

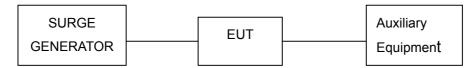
8.1 TEST EQUIPMENT

EQUIPMENT / FACILITIES	MANUFACTURER	MODEL#/ SERIAL#	DUE DATE OF CAL. & CAL. CENTER
SURGE TEST	SCHAFFNER	NSG 2050 /	OCT. 2003
(System Mainframe)	SCHAFFINER	199904-057SC	ETC
SURGE TEST	SCHAFFNER	PNW 2050 /	OCT. 2003
(Impulse Network)	SCHAFFINER	256	ETC
SURGE TEST	SCHAFFNER	CDN 131/133 /	OCT. 2003
(Pulse Coupling Network)	SUPARTINER	520	ETC

8.2 TEST PROCEDURE

According to IEC/EN 61000-4-5:1995

8.3 TEST SET-UP



NOTE:

- 1. The EUT system was put on a wooden table with 0.8m height above ground reference plane.
- 2. For the actual test configuration, please refer to the photos of testing.

8.4 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

8.5 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.



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8.6 TEST CONDITION / PERFORMANCE CRITERIA

1. Test condition

(1) Test level : Common mode : ±0.5kV, ±1kV, ±2kV

Differential mode: ±0.25kV, ±0.5kV, ±1kV

(2) Number of Pulse : 5

(3) Phase : 0°, 90°, 180°, 270°

(4) Polarity : Positive and Negative polarization

(5) Repetition : 60 s

(6) Waveform : 1.2/50 µs (open circuit)

(7) Standard requirement : Criterion B

2. Performance criterion

(1) Criterion A : Normal performance during test

(2) Criterion B : Temporary degradation or loss of function

or performance which is self-recoverable

(3) Criterion C : Temporary degradation or loss of function

or performance which requires operator

intervention system reset

8.7 SUMMARY OF TEST RESULT

Temperature:	26 °C	Humidity:	46% RH
Test Mode:	N/A	Tested By:	Nissan Yi
Atmospheric Air Pressure:	101.2 kPa	Tested Date:	Sep. 30, 2003

Test Result : Criterion A pass

Mode	Coupling	Voltage	Phase			
Wode	Coupling	voltage	0 °	90°	180°	270°
		+/-0.5kV	Α	Α	А	А
Common	L + PE N + PE	+/-1kV	Α	Α	Α	А
	=	+/-2kV	Α	Α	Α	Α
	al L+N	+/-0.25kV	А	А	А	А
Differential		+/-0.5kV	Α	Α	Α	Α
		+/-1kV	Α	Α	Α	Α

NOTE:

Description of test observation:

A: There was no change compared with initial operation during the test.



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9. INDUCED RF FIELDS (CONDUCTED SUSCEPTIBILITY) TEST

9.1 TEST EQUIPMENT

EQUIPMENT / FACILITIES	MANUFACTURER	MODEL # / SERIAL #	DUE DATE OF CAL. & CAL. CENTER	FINAL TEST BE USED
EM INJECTION CLAMP	FCC	F-203I-23mm/ 110	MAY 2004 ETC	
POWER LINE CDN	FCC	FCC-801-M4-32A/ 9808	MAY 2004 ETC	
POWER LINE CDN	FCC	FCC-801-M5-32A/ 9812	MAY 2004 ETC	
POWER LINE CDN	FCC	FCC-801-M1-32A/ 9820	MAY 2004 ETC	
SIGNAL LINE CDN	FCC	FCC-801-T2/ 9830	MAY 2004 ETC	
SIGNAL LINE CDN	FCC	FCC-801-T4/ 9831	MAY 2004 ETC	√
SIGNAL LINE CDN	FCC	FCC-801-T6/ 9832	MAY 2004 ETC	
SIGNAL LINE CDN	FCC	FCC-801-S9/ 9843	MAY 2004 ETC	
POWER LINE CDN	FCC	FCC-801-M2-32A/ 9840	NOV. 2003 ETC	
SIGNAL GENERATOR	HP	8648A/ 3636A02776	JUN. 2004 ETC	V
POWER AMPLIFIER	A.R.	150A100A/ 19553	MAY 2004 ETC	V
DUAL DIRECTION COULPER	A.R.	DC2600/ 25893	AUG. 2004 ETC	V
POWER METER	BOONTON	4232A/ 29001	MAY 2004 ETC	V
SIGNAL LINE CDN	FCC	FCC-801-S25/ 9845	MAY 2004 ETC	
POWER LINE CDN	FCC	FCC-801-M3-32A/ 9874	MAY 2004 ETC	V
T2	EM-TEST	ATT6/75/ 1001-40	N/A	√
COAXIAL CABLE	SUNCITY	CABLE14/ #14-1M	APR. 2004 SRT	V
COAXIAL CABLE	SUNCITY	CABLE05/ #5-5M	APR. 2004 SRT	V
COAXIAL CABLE	SUNCITY	J400/ 2M	APR. 2004 SRT	V



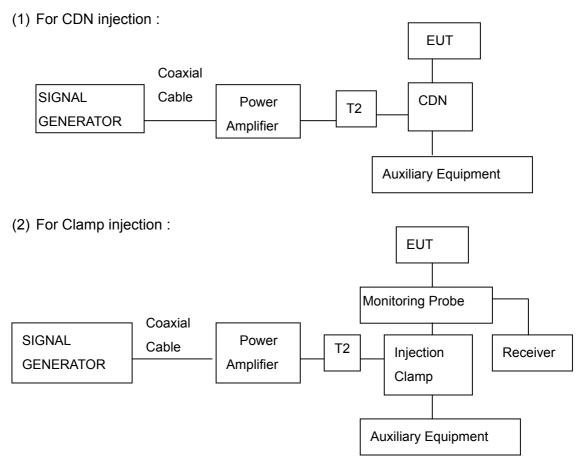
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9.2 TEST PROCEDURE

According to IEC/EN 61000-4-6:1996

9.3 TEST SET-UP



NOTE:

- 1. The EUT system was put on a wooden table with 0.1m height above ground.
- 2. For the actual test configuration, please refer to the photos of testing.
- 3. The distance between CDN(Clamp) and EUT was controlled between 0.1m and 0.3m.
- 4. The model no. of the CDN connected to EUT is FCC-801-M3-32A.

9.4 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

9.5 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.



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9.6 TEST CONDITION / PERFORMANCE CRITERIA

1. Test condition

(1) Source voltage and frequency : 230 V/ 50 Hz, single phase

(2) Sweeping frequency : 150 kHz – 80 MHz

(3) Test level : 3 V, the frequency step is 1%

(4) Modulation : AM 80%, 1 kHz

(5) Dwell time for each frequency : 3 sec(6) Standard requirement : Criterion A

2. Performance criterion

(1) Criterion A : Normal performance during test

(2) Criterion B : Temporary degradation or loss of function

or performance which is self-recoverable

(3) Criterion C : Temporary degradation or loss of function

or performance which requires operator

intervention system reset

9.7 SUMMARY OF TEST RESULT

Temperature:	26°C	Humidity:	45% RH
Test Mode:	N/A	Tested By:	Nissan Yi
Test Result :	Criterion A pass	Tested Date:	Sep. 30, 2003

FREQUENCY	LEVEL	MODULATION	INJECTION METHOD	TEST RESULT (CRITERION)
150kHz - 80MHz	3V	80% AM, 1 kHz	М3	Α
150kHz - 80MHz	3V	80% AM, 1 kHz	T4	A

NOTE:

Description of test observation:

A: There was no change compared with initial operation during the test.



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10. POWER FREQUENCY MAGNETIC-FIELD TEST

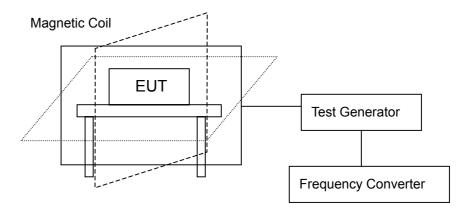
10.1 TEST EQUIPMENT

EQUIPMENT / FACILITIES	MANUFACTURER	MODEL#/ SERIAL#	DUE DATE OF CAL. & CAL. CENTER	
MAGNETIC FIELD	HAEFELY	MAG 100.1/	JAN. 2004	
TESTER	HACFELT	080.015-04	SRT	
MAGNETIC FIELD	HAEFELY	MAG 100.1/	JAN. 2004	
COIL	HAEFELT	080.015-04	SRT	
MAGNETIC FIELD METER	F.W.BELL	4080/ 19990416	MAR. 2004 ITRI	

10.2 TEST PROCEDURE

According to IEC/EN 61000-4-8:1993

10.3 TEST SET-UP



NOTE:

- 1. The EUT system was put on a wooden table with 0.8m height above ground.
- 2. For the actual test configuration, please refer to the photos of testing
- 3. 1A/m = 12.56mG, 3A/m = 37.68mG, 10A/m = 125.6mG,

10.4 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.



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10.5 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.

10.6 TEST CONDITION / PERFORMANCE CRITERIA

1. Test condition

(1) Test axis : X, Y and Z axes (2) Test time : 5 min / each axis

(3) Field strength : 3 A/m(4) Standard requirement : Criterion A

2. Performance criterion

(1) Criterion A : Normal performance during test

(2) Criterion B : Temporary degradation or loss of function

or performance which is self-recoverable

(3) Criterion C : Temporary degradation or loss of function

or performance which requires operator

intervention system reset

10.7 SUMMARY OF TEST RESULT

Temperature:	26°C	Humidity:	49%H
Test Mode:	N/A	Tested By:	Nissan Yi
Frequency of Magnetic Field:	■ 50Hz, □60Hz	Tested Date:	Sep. 29, 2003

Test Result : Criterion A pass

ORIENTATION	FIELD STRENGTH	TEST RESULT (CRITERION)
X	3 A/m	Α
Y	3 A/m	А
Z	3 A/m	Α

NOTE:

Description of test observation:

A: There was no change compared with initial operation during the test.



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11. VOLTAGE DIPS, INTERRUPTS, VARIATIONS TEST

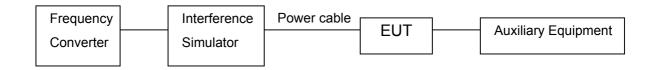
11.1 TEST EQUIPMENT

EQUIPMENT / FACILITIES	MANUFACTURER	MODEL # / SERIAL #	DUE DATE OF CAL. & CAL. CENTER
INTERFERENCE	HAFFELY	PLINE 1610/	APR. 2004
SIMULATOR	NACFELT	083-732-05	ETC

11.2 TEST PROCEDURE

According to IEC/EN 61000-4-11:1994

11.3 TEST SET-UP



NOTE:

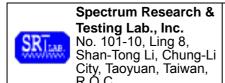
- 1. The EUT system was put on a wooden table with 0.8m height above ground.
- 2. For the actual test configuration, please refer to the photos of testing.

11.4 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

11.5 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.



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11.6 TEST CONDITION / PERFORMANCE CRITERIA

١.	Test		

(1) Source voltage and frequency(2) Test level(2) Test level(3) Test level(4) Dip depth 95%, 0.5 period

30%, 25 period

Interrupt 95%, 250 period

(3) Phase : 0°, 180°

(4) Test duration : 2min each phase

(5) Time between test : 10 sec

(6) Standard requirement : Dip 95% : Criterion B; Dip 30% : Criterion C;

Interrupt > 95%: Criterion C

2. Performance criterion

(1) Criterion A : Normal performance during test

(2) Criterion B : Temporary degradation or loss of function

or performance which is self-recoverable.

(3) Criterion C : Temporary degradation or loss of function

or performance which requires operator

intervention system reset.

11.7 SUMMARY OF TEST RESULT

Temperature:	27°C	Humidity:	48% RH
Test Mode:	N/A	Tested By:	Nissan Yi
		Tested Date:	Sep. 29, 2003

AC POWER	DIP DEPTH	INTERVAL	DIP TIME	TEST TIME	PHASE	TEST RESULT (Criterion)
230V/50Hz	95%	10 sec	0.5 period	2 min	0°	A
			·		180°	Α
	30%	6 10 sec	25 period	2 min	0°	Α
	30 /6				180°	Α
	95%	10 sec	250 period	2 min	0°	С
	(interrupt)	10 560			180°	O

NOTE:

- 1. The power voltage range: 115 V to 240 V, and the range 125 V is 109 % of the lowest voltage.
- 2. Description of test observation:
 - A: There was no change compared with initial operation during the test.
 - C: EUT requires operator intervention system reset.



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12. PHOTOS OF TESTING

- Conducted test







Spectrum Research & Testing Lab., Inc.
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City, Taoyuan, Taiwan,
R.O.C.

TEST REPORT

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- Radiated test







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- Harmonics test



- Voltage fluctuations test





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- Electrostatic discharge immunity test



- Electrical fast transient / burst immunity test





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- Radiated immunity test







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-Surge test (power line)



- Inducted RF fields (conducted susceptibility) test





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- Power frequency magnetic-field test



- Voltage dips, interrupts, variations test





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13. TERMS OF ABRIVATION

AV.	Average detection
AZ(°)	Turn table azimuth
Correct.	Correction
EL(m)	Antenna height (meter)
EUT	Equipment Under Test
Horiz.	Horizontal direction
LISN	Line Impedance Stabilization Network
NSA	Normalized Site Attenuation
Q.P.	Quasi-peak detection
SRT Lab	Spectrum Research & Testing Laboratory, Inc.
Vert.	Vertical direction